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May 2015

FQD2P40

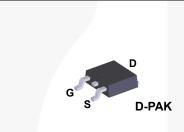
P-Channel QFET[®] MOSFET -400 V, -1.56 A, 6.5 Ω

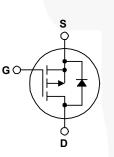
Description

This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance . Low Crss (Typ. 6.5 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.. • RoHS Compliant

Features

- -1.56 A, -400 V, $R_{DS(on)}$ = 6.5 Ω (Max.) @ V_{GS} = -10 V, I_D = -0.78 A
- Low Gate Charge (Typ. 10 nC)
- 100% Avalanche Tested





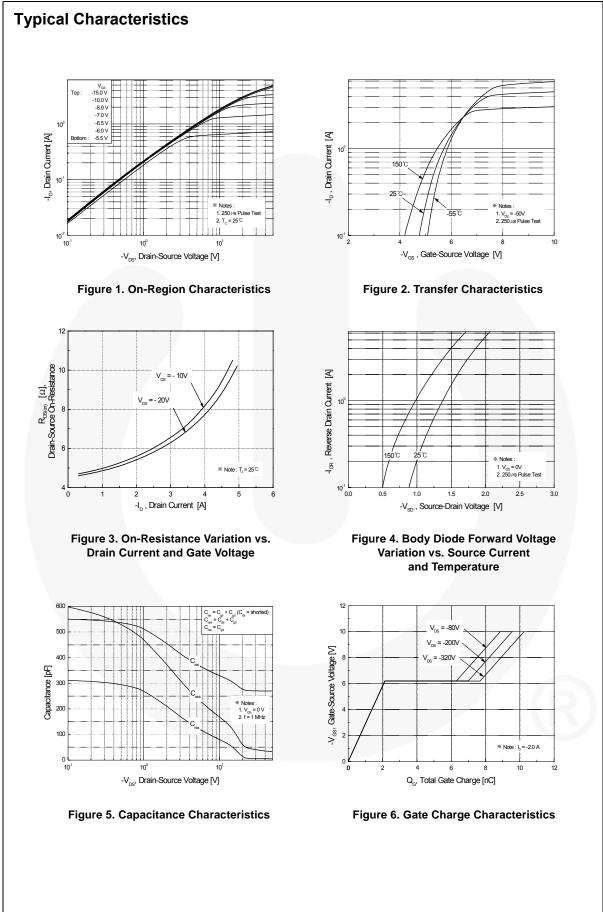
Absolute Maximum Ratings T_c = 25°C unless otherwise noted.

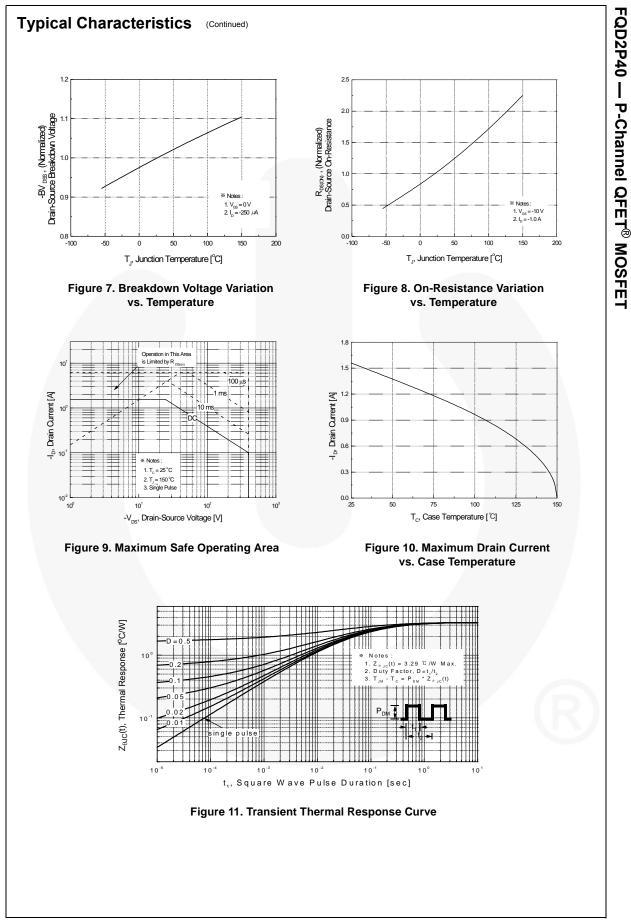
Symbol	Parameter		FQD2P40TM	Unit
V _{DSS}	Drain-Source Voltage		-400	V
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)		-1.56	А
	- Continuous (T _C = 100°C)		-0.98	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-6.24	A
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	120	mJ
I _{AR}	Avalanche Current	(Note 1)	-1.56	A
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.8	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
_	Power Dissipation ($T_C = 25^{\circ}C$)		38	W
	- Derate above 25°C		0.3	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering, 1/8" from case for 5 seconds		300	°C

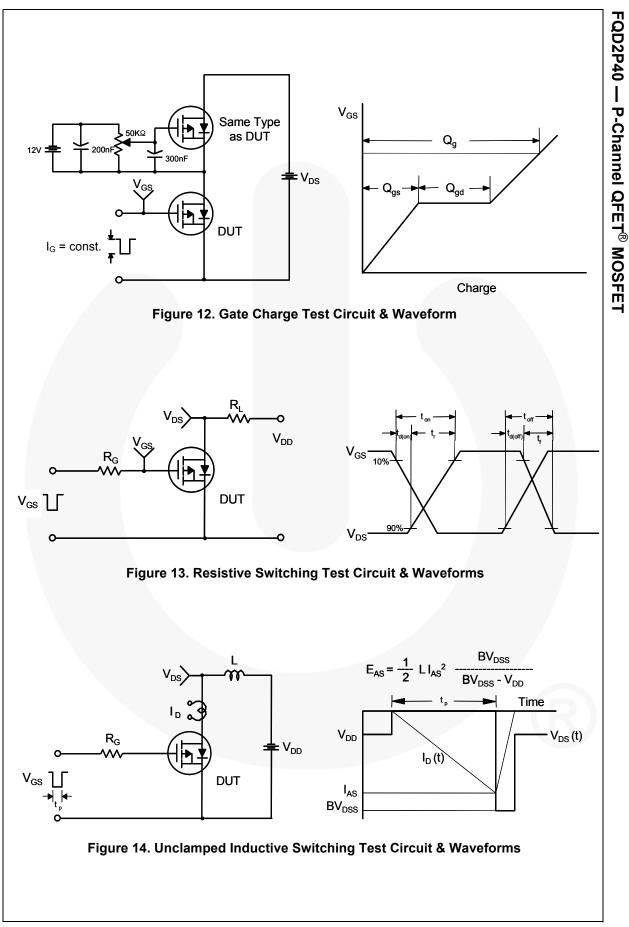
Thermal Characteristics

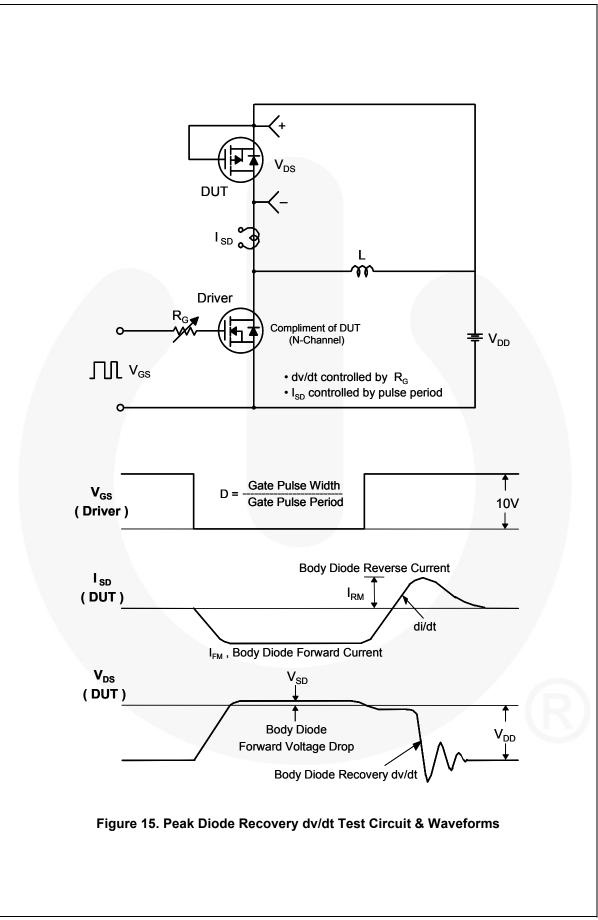
Symbol	Parameter	FQD2P40TM	Unit
R_{\thetaJC}	Thermal Resistance, Junction to Case, Max.	3.29	
D	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	110	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2-oz Copper), Max.	50	

racteristi Drain-Sour Breakdowr Coefficient	ce Breakdown Volta	D-P T _C = 25°C		Tape an	d Reel	330 ו	nm	16 mr	n	000
racteristi Drain-Sour Breakdowr Coefficient	Parameter CS rce Breakdown Volta	T _C = 25°C	unless oth		PAK Tape and Reel 330			16 mm		2500 units
Drain-Sour Breakdowr Coefficient	cs ce Breakdown Volta			erwise noted.						
Drain-Sour Breakdowr Coefficient	cs ce Breakdown Volta			Test Cond	litions		Min.	Тур.	Max	. Unit
Drain-Sour Breakdowr Coefficient	ce Breakdown Volta							.,,,,,		
Breakdowr Coefficient		200	Voo =	0 V, I _D = -25	ΟΠΑ		-400			V
	Breakdown Voltage Temperature		$I_D = -250 \mu\text{A}$, Referenced to 25°C				-400	-		V/°C
Zero Gate			-	-400 V, V _{GS}					-1	μΑ
	Voltage Drain Curre	ent		-320 V, T _C =					-10	μΑ
Gate-Body	Leakage Current, F	orward	V _{GS} =	-30 V, V _{DS} =	• 0 V				-100	nA
	Leakage Current, F		V _{GS} =	30 V, V _{DS} =	0 V				100	nA
racteristi	cs									
			V _{DS} =	V _{GS} , I _D = -2	50 µA		-3.0		-5.0	V
								5.0	6.5	Ω
			V _{DS} =	-50 V, I _D = -0).78 A			1.26		S
			1					270	250	
			20	00	: 0 V,					pF
			f = 1.0	MHz						pF pF
	,	_		-	-2.0 A,			9	30	ns
Turn Off D			$R_{c} = 2$					33	75	ns
Turn-On D	elay Time	-	R _G = 2	.5 22				33 22	75 55	ns ns
Turn-Off Fa	,	_	. R _G = 2	.5 22	(Note 4)				
	all Time					Note 4)		22	55	ns
Turn-Off Fa	all Time Charge			-320 V, I _D =		Note 4)		22 25	55 60	ns
Turn-Off Fa Total Gate	all Time Charge ce Charge		V _{DS} =	-320 V, I _D =	-2.0 A,	Note 4) Note 4)		22 25 10	55 60 13	ns ns nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain	all Time Charge ce Charge o Charge	stics ar	V _{DS} = V _{GS} =	-320 V, I _D = -10 V	-2.0 A,			22 25 10 2.1	55 60 13 	ns ns nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain	all Time Charge ce Charge		V _{DS} = V _{GS} =	-320 V, I _D = -10 V kimum Ra	-2.0 A,			22 25 10 2.1	55 60 13 	ns ns nC nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain	all Time Charge ce Charge charge charge	ource Dic	V _{DS} = V _{GS} = nd Max	-320 V, I _D = -10 V kimum Ra rard Current	-2.0 A,			22 25 10 2.1 5.5	55 60 13 	ns ns nC nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drair Ource Did Maximum Maximum	all Time Charge ce Charge n Charge ode Characteris Continuous Drain-S	ource Dic e Diode F	V _{DS} = V _{GS} = nd Max de Forw	-320 V, I _D = -10 V kimum Ra rard Current	-2.0 A, tings			22 25 10 2.1 5.5	55 60 13 	ns ns nC nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain Ource Did Maximum Maximum Drain-Sour	all Time Charge ce Charge d Charge ode Characteri s Continuous Drain-S Pulsed Drain-Sourc	ource Dic e Diode F	$V_{DS} =$ $V_{GS} =$ nd Max de Forw forward $V_{GS} =$	-320 V, I _D = -10 V kimum Ra rard Current Current	-2.0 A, htings		 	22 25 10 2.1 5.5	55 60 13 -1.56 -6.24	ns nC nC nC A A
	Gate Thres Static Drain On-Resista Forward Tr c Charac Input Capa Output Capa Reverse Tr ng Chara Turn-On D	racteristics Gate Threshold Voltage Static Drain-Source On-Resistance Forward Transconductance c Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Turn-On Rise Time	Gate Threshold Voltage Static Drain-Source On-Resistance Forward Transconductance C Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time	Gate Threshold Voltage V _{DS} = Static Drain-Source V _{GS} = On-Resistance V _{DS} = Forward Transconductance V _{DS} = c Characteristics V _{DS} = Input Capacitance V _{DS} = Output Capacitance f = 1.0 Reverse Transfer Capacitance V _{DD} = Turn-On Delay Time V _{DD} =	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -2i$ Static Drain-Source On-Resistance $V_{GS} = -10 \text{ V}$, $I_D = -4i$ Forward Transconductance $V_{DS} = -50 \text{ V}$, $I_D = -6i$ Forward Transconductance $V_{DS} = -50 \text{ V}$, $I_D = -6i$ C CharacteristicsInput CapacitanceOutput Capacitance $V_{DS} = -25 \text{ V}$, $V_{GS} = -25 \text{ V}$, $V_{GS} = -25 \text{ V}$ Reverse Transfer Capacitance $f = 1.0 \text{ MHz}$ ng CharacteristicsTurn-On Delay Time $V_{DD} = -200 \text{ V}$, $I_D = -200 \text{ V}$, $I_D = -200 \text{ V}$	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ c Characteristics $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ Input Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHzReverse Transfer Capacitance $f = 1.0 \ MHz$ num-On Delay Time $V_{DD} = -200 \ V$, $I_D = -2.0 \ A$,	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ c Characteristics Input CapacitanceInput Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHzReverse Transfer Capacitance $f = 1.0 \ MHz$ ng Characteristics Turn-On Delay TimeV_{DD} = -200 \ V, $I_D = -2.0 \ A$,	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ -3.0Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ c Characteristics $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ Input Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHzReverse Transfer Capacitance $r = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHz ng Characteristics Turn-On Delay Time $V_{DD} = -200 \ V$, $I_D = -2.0 \ A$,	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ -3.0Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ 5.0Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ 1.26C CharacteristicsInput Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHz270Output Capacitance $F = 1.0 \ MHz$ 6.5Input CapacitanceInput CapacitanceP and the second sec	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ 3.05.0Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ 5.06.5Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ 1.26c CharacteristicsInput Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHz270350Output Capacitancef = 1.0 \ MHz4560Reverse Transfer CapacitanceTurn-On Delay Time











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